Re f#	Hits	Search Query	DBs	Defau It Oper ator	Plur als	Time Stamp
L1	327	324/76.13.ccls.	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06
L2	315	326/104.ccls.	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06
L3	352	G01D001/14.ipc.	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06

L4	6	((electric OR electronic) NEAR elements) SAME "measurement circuit"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	OFF	2006/06/28 06:06
L5	400	elements WITH "measurement circuit"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	OFF	2006/06/28 06:06
L6	16	disturbance WITH "electric\$ pulse"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06

L7	3	"external disturbance" SAME "electric\$ pulse"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06
L8	21	"signal sampling" NEAR measuring	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06
L9	392	"signal samr ng" WITH measuring	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06

L1 0	73	disturbance SAME "electric\$ pulse"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 06:06
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Re f #	Hits	Search Query	DBs	Defau It Oper ator	Plur als	Time Stamp
L1 4	1	("duration and/or shape" SAME "integrated circuit"). clm.	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 07:35
L1 5	0	("duration or shape" SAME "integrated circuit").clm.	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2006/06/28 07:35